Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/673,336	TANAKA ET AL.
Examiner	Art Unit
Chuc D. Tran	2821

SEARCHED					
Class	Subclass	Date	Examiner		
343	700 MS	7/17/2006	тс		
343	729,829	7/17/2006	тс		
343	846,853	7/17/2006	TC		
343	860,909	7/17/2006	TC		
·					
- 12					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
343	700 MS	7/17/2006	тс	
343	909	7/17/2006	тс	
Interference Search History		7/17/2006	тс	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
BRS Consulted with Primary HoangAnh Le	7/17/2006	тс		